

- Ideal for 300.00 MHz Transmitters
- Very Low Insertion Loss
- Quartz Stability
- Ultra Miniature Ceramic SMD Package (QCC8C)

SR5401

Absolute Maximum Rating (Ta=25°C)							
Parameter		Rating	Unit				
CW RF Power Dissipation	Р	0	dBm				
DC Voltage	V_{DC}	±30	V				
Operating Temperature Range	T _A	-10 ~ +60	°C				
Storage Temperature Range	\mathcal{T}_{stg}	-40 ~ +85	°C				

Electronic Characteristics						
	Parameter	Sym	Minimum	Typical	Maximum	Unit
Frequency (25°C)	Nominal Frequency	f _c	NS	300.00	NS	MHz
	Tolerance from 300.00 MHz	Δf_c	-	-	± 75	KHz
Insertion Loss		IL	-	1.5	2.0	dB
Quality Factor	Unloaded Q-Value	Qu	-	12,525	-	-
	50Ω Loaded Q-Value	$Q_{\scriptscriptstyle L}$	-	2,000	-	-
Temperature Stability	Turnover Temperature	To	25	-	55	°C
	Turnover Frequency	fo	-	f_c	-	KHz
	Frequency Temperature Coefficient	FTC	-	0.032	-	ppm/°C2
Frequency Aging	Absolute Value during the First Year	$ f_A $	-	-	10	ppm/yr
DC Insulation Resistance Bo	ation Resistance Between any Two Pins - 1.0		-	MΩ		
RF Equivalent RLC Model	Motional Resistance	R _M	-	19	26	Ω
	Motional Inductance	L _M	-	126.3270	-	μН
	Motional Capacitance	C _M	-	2.2302	-	fF
	Shunt Static Capacitance	Co	2.35	2.65	2.95	pF

NS = Not Specified

Note:

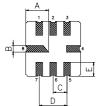
- The frequency f_c is the frequency of minimum IL with the resonator in the specified test fixture in a 50Ω test system with VSWR ≤ 1.2:1.
- 2. Unless noted otherwise, case temperature TC = +25°C±2°C.
- 3. Frequency aging is the change in fC with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
- Turnover temperature, T0, is the temperature of maximum (or turnover) frequency, f0. The nominal frequency at any case temperature, TC, may be calculated from: f = f₀ [1 - FTC (T₀ - T_C)²].
- 5. This equivalent RLC model approximates resonator performance near the resonant frequency and is provided for reference only. The capacitance C₀ is the measured static (nonmotional) capacitance between input terminal and ground or output terminal and ground.

- The measurement includes case parasitic capacitance.
- Derived mathematically from one or more of the following directly measured parameters: f_c, IL, 3 dB bandwidth, f_C versus T_C, and Co.
- The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
- Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
- Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.
- For questions on technology, prices and delivery, please contact our sales offices or e-mail to sales@vanlong.com.

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Package Dimensions (QCC8C)







Package Dimensions

Dimensions	Nom (mm)	Dimensions	Nom (mm)
A	2.08	Е	1.20
В	0.60	F	1.35
С	1.27	G	5.00
D	2.54	Н	5.00

Connection

Terminal 1

Terminal 2 Case-Ground

NC

Marking

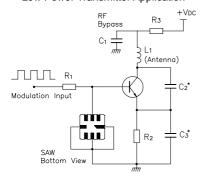


- 1. R5401 Part Code
- 2. Frequency in MHz
- 3. Date Code:

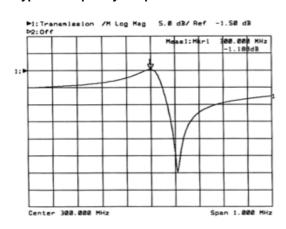
Y: Last digit of year WW: Week No.

Typical Application Circuit

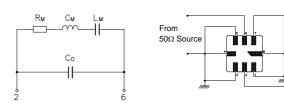
Low Power Transmitter Application



Typical Frequency Response



Equivalent LC Model and Test Circuit



Equivalent LC Model

Electrical Connections

Terminals

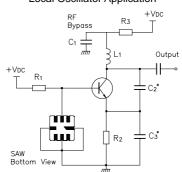
6

4,8 1,3,5,7

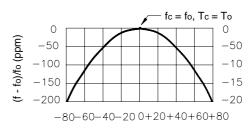
Test Circuit

To 50Ω load

Local Oscillator Application



Temperature Characteristics



 $\Delta T = Tc - To (°C)$

The curve shown above accounts for resonator contribution only and does not include oscillator temperature characteristics.

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